

# BarÄ±Å KÄ±nacÄ±

## List of Publications by Year in descending order

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22  
papers

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840776  
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22  
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docs citations

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times ranked

302  
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#	ARTICLE	IF	CITATIONS
1	Dielectric Properties of Au/SrTiO <sub>3</sub> /p-Si Structure Obtained by RF Magnetron Sputtering in a Wide Frequency Range. <i>Silicon</i> , 2022, 14, 2717-2722.	3.3	6
2	Influence of V <sub>2</sub> O <sub>5</sub> and B <sub>2</sub> O <sub>3</sub> addition on the sintering behaviour and physical properties of ZnO ceramics. <i>Processing and Application of Ceramics</i> , 2022, 16, 48-54.	0.8	1
3	Evaluation of dielectric properties of Au/TZO/n-Si structure depending on frequency and voltage. <i>Journal of Materials Science: Materials in Electronics</i> , 2022, 33, 10516-10523.	2.2	3
4	Functional optical design of thickness-optimized transparent conductive dielectric-metal-dielectric plasmonic structure. <i>Scientific Reports</i> , 2022, 12, .	3.3	9
5	The temperature dependent negative dielectric constant phenomena of Au/n-GaAs structure with CZO interfacial layer. <i>Journal of Materials Science: Materials in Electronics</i> , 2021, 32, 5928-5935.	2.2	4
6	Modeling and Experimental Analysis of Photovoltaic Parameters of GaInP/GaAs Dual Junction p-n Solar Cell. <i>Brazilian Journal of Physics</i> , 2021, 51, 553-558.	1.4	3
7	Determination of surface morphology and electrical properties of MoO <sub>3</sub> layer deposited on GaAs substrate with RF magnetron sputtering. <i>Journal of Materials Science: Materials in Electronics</i> , 2021, 32, 12330-12339.	2.2	9
8	Design and fabrication of a semi-transparent solar cell considering the effect of the layer thickness of MoO <sub>3</sub> /Ag/MoO <sub>3</sub> transparent top contact on optical and electrical properties. <i>Scientific Reports</i> , 2021, 11, 13079.	3.3	25
9	Structural, morphological, optical and electrical properties of the Ti doped-ZnO (TZO) thin film prepared by RF sputter technique. <i>Physica B: Condensed Matter</i> , 2021, 616, 413126.	2.7	13
10	Investigation of the effect of annealing on the structural, morphological and optical properties of RF sputtered WO <sub>3</sub> nanostructure. <i>Physica B: Condensed Matter</i> , 2021, 622, 413350.	2.7	11
11	Investigation of V-groove fabricated GaInNAs nipi solar cell structure. <i>Optical and Quantum Electronics</i> , 2021, 53, 1.	3.3	0
12	The effect of thickness on surface structure of rf sputtered TiO <sub>2</sub> thin films by XPS, SEM/EDS, AFM and SAM. <i>Vacuum</i> , 2020, 182, 109766.	3.5	68
13	A comprehensive study on Cu-doped ZnO (CZO) interlayered MOS structure. <i>Journal of Materials Science: Materials in Electronics</i> , 2020, 31, 13646-13656.	2.2	18
14	Negative capacitance phenomena in Au/SrTiO <sub>3</sub> /p-Si heterojunction structure. <i>Journal of Materials Science: Materials in Electronics</i> , 2020, 31, 8718-8726.	2.2	14
15	Characterization of a GaAs/GaAsBi pin solar cell. <i>Semiconductor Science and Technology</i> , 2019, 34, 085001.	2.0	14
16	V-groove etched 1-eV-GaInNAs nipi solar cell. <i>Applied Physics A: Materials Science and Processing</i> , 2019, 125, 1.	2.3	6
17	Performance evaluation of a GaInP/GaAs solar cell structure with the integration of AlGaAs tunnel junction. <i>Solar Energy Materials and Solar Cells</i> , 2015, 137, 1-5.	6.2	36
18	AZO thin film-based UV sensors: effects of RF power on the films. <i>Applied Physics A: Materials Science and Processing</i> , 2015, 119, 965-970.	2.3	24

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19	Analysis of the Temperature Dependence of the Capacitanceâ€“Voltage and Conductanceâ€“Voltage Characteristics of Au/TiO2(rutile)/n-Si Structures. Journal of Electronic Materials, 2013, 42, 1108-1113.	2.2	21
20	The temperature dependent analysis of Au/TiO2 (rutile)/n-Si (MIS) SBDs using currentâ€“voltageâ€“temperature (Iâ€“Vâ€“T) characteristics. Materials Science in Semiconductor Processing, 2012, 15, 531-535.	4.0	36
21	Analysis of the forward and reverse bias <i>I-V</i> characteristics on Au/PVA:Zn/n-Si Schottky barrier diodes in the wide temperature range. Journal of Applied Physics, 2011, 109, .	2.5	48
22	Effect of different <i>P</i> / <i>As</i> ratio on the optical and structural properties of GaAs <sub>1-x</sub> <i>P</i> <sub>x</sub> /GaAs. Surface and Interface Analysis, 2010, 42, 1252-1256.	1.8	5